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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of: Seiki TAKAHASHI

Serial Number: Not Yet Assigned

(Continuation of International application No.: PCT/JP03/04581)

Filed: October 8, 2004

For: NONDESTRUCTIVE INSPECTION METHOD OF GRAIN-BOUNDARY ATTACK OF

CHROMIUM-CONTAINING NICKEL-BASED ALLOY AND INSPECTION

APPARATUS FOR USE THEREIN

Attorney Docket No.: 042779

Customer No.: 38834

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P. O. Box 1450 Alexandria, VA 22313-1450

October 8, 2004

Sir:

In compliance with 37 CFR 1.56, Applicant(s) call(s) to the attention of the Patent and Trademark Office the references listed on the attached PTO-1449, except for the U.S. references and cited in the enclosed international search report.

In the event there are any fees due in connection with the filing of this paper, please charge Deposit Account No. <u>50-2866</u>.

Respectfully submitted,

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Enclosures: PTO-1449; International Search Report

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INFORMATION	Attv. Docket No. 042779	Serial No. New Appln.
DISCLOSURE STATEMENT	Applicant(s): Seiki TAKAHASHI	
PTO-1449	Filing Date: October 8, 2004	Group Art Unit:

U.S. PATENT DOCUMENTS

Examiner Initial		Document No.	Name	Date	Class	Subclass	Filing Date (If appropriate)
	AA						1
	AB						
	AC						
	AD						

FOREIGN PATENT DOCUMENTS

	Document No.	Date	Country	Translation (Yes or No)
 AE AF	55-42060 54-156697	03/25/80 12/10/79	Japan Japan	Cited in the Int'l Search Rep. Cited in the Int'l Search Rep.
AG	2001-141700	05/25/01	Japan	Cited in the Int'l Search Rep.
 AH AI AJ AK				

OTHER DOCUMENTS

	AL AM	Microfilm of the specification and drawings annexed to the request of a Japanese Utility Model Application No. 170482/1988 (Laid-open No. 91980/1990) (Sumitomo Heavy Industries, Ltd.), 20 July, 1990 (20.07.90) Full text; Figs. 1 to 2 (Family: none)
Examiner		Date Considered